FEE TRANSMITTAL for FY 2005 Patent fees are subject to annual revision.

nt claims small entity status. See 37 CFR 1.27

TOTAL AMOUNT OF PAYMENT

(\$) 380

	Complete if Known	
Serial No.	10/748,827	_
Filing Date	December 29, 2003	
First Inventor	Joonhyung Kwon	
Examiner	Larkin, Daniel Sean	
Art Unit	2856	
Docket No.	PSI004-1C US	

METHOD OF PAYMENT	FEE CALCULATION (continued)					
☑ Check ☐ Credit Card ☐ Money Order ☐ Other ☐ None						
Deposit Account	Large Er	ntity	Small E	intity		
Deposit	Fees Code	(\$)	Fees	(\$)	Fee Description	Fees
Account 50-2263 Number				("		Paid
Deposit	1051	130	2051	65	Surcharge - late filing fee or oath	
Account Name Silicon Valley Patent Group LLP	1052	50	2052	25	Surcharge - late provisional filing fee or cover sheet	
	1053	130	1053	130	Non-English specification	
The Director is authorized to: (check all that apply) Charges fees(s) indicated below Credit any Overpayments	1812	2,520	1812	2,520	For filing a request for ex parte	
	1804	920*	1804	920*	reexamination Requesting publication of SIR prior to	-
Charges any additional fee(s) or any underpayment of fee(s)	1805	1,840*	1805	1,840*	Examiner action Requesting publication of SIR after	
Charges fee(s) indicated below, except for the filing fee to the above- identified deposit account.	1251	120		60	Examiner action	
FEE CALCULATION	ł ———	<u> </u>	2251	 	Extension for reply within one month Extension for reply within second	
1. BASIC FILING FEE	1252	450	2252	225	month_	
	1253	1020	2253	510	Extension for reply within third month	
Large Entity Fee Small Entity Fee Fee Description Fee Paid Code (\$) Code (\$)	1254	1,590	2254	795	Extension for reply within fourth month	
1001 790 2001 395 Utility Filing Fee	1255	2,160	2255	1,080	Extension for reply within fifth month	
1002 350 2002 175 Design Filing Fee	1401	500	2401	250	Notice of Appeal	
1003 550 2003 275 Plant Filing Fee 1004 790 2004 395 Reissue Filing Fee	1402	500	2402	250	Filing a brief in support of an appeal	
1005 160 2005 80 Provisional Filing Fee	1403	1000	2403	500	Request for oral hearing	-
	1451	1,510	1451	1,510	Petition for a public use proceeding	
SUBTOTAL (1) (\$)	1452	500	2452	250	Petition to revive - unavoidable	
	1453	1,500	2453	750	Petition to revive - unintentional	
2. EXTRA CLAIM FEES FOR UTILITY AND REISSUE	1501	1,400	2501	700	Utility issue fee (or reissue)	
Extra Fee from	1502	130	2502	65	Design issue fee	
Claims below Fee Paid	1503	160	2503	80	Plant issue fee	
Independent	1460		·		***	
Claims	<u> </u>	130	1460	130	Petitions to the Commissioner Processing fee for provisional	
wintiple Dependent x =	1807	50	1807	50	applications Submission of Information Disclosure	
Large Entity Fee Small Entity Fee Fee Description	1806	180	1806	180	Statement	180
Code (\$) Code (\$)	8021	40	8021	40	Recording each patent assignment per properties (times number of	
1202 50 2202 25 Claims in excess of 20 1201 200 2201 100 Independent claims in excess of 3	1809	790	2809	395	properties) Filing a submission after final rejection	
1203 360 2203 180 Multiple dependent claim, if not paid 1204 200 2204 100 * Reissue independent claims over	1810				(37 CFR § 1.129(a)) For each additional invention to be	
		790	2810	395	examined (37 CFR § 1.129(b)) Request for Continued Examination	
over original patent	1801	790	2801	395	(RCE) Request for expedited examination of	
	1802 Other Fee	900 (specify)	1802	900	a design application	
SURTOTAL (2)	Owier Pee	(apecity)		_		
SUBTOTAL (2) (\$) 200	* Reduce	d by Basic	Filing Fee	Paid	SUBTOTAL (3) (\$) 18	80
** or number previously paid if greater; For Reissues see above					(\$) ((

Submitted By						
Name (Print/Type)	Omkar K. Suryadevara	Registration No. (Attorney/Agent)	36,320	Telephone	(408) 982-8203	
Signature S. Omkor		Date	February 1,	2005		



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Inventors: Joonhyung Kwon; Young Seok Kim; Sang-il Park

Assignee: PSIA Corporation

Title: Scanning Probe Microscope With Improved Probe Tip Mount

Serial No.: 10/748,827 Filing Date: December 29, 2003

Examiner: Larkin Group Art Unit: 2881

Docket No.: PSI004-1C US Confirmation No: 7166

Santa Clara, California February 1, 2005

Mail Stop AMENDMENT 02/08/2005 BABRAHA1 00000090 10748827

COMMISSIONER FOR PATENTS 01 FC:1806 180.00 OP

P.O. BOX 1450 ALEXANDRIA, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR §1.97(c)

Dear Sir:

Pursuant to 37 C.F.R. § 1.56, §1.97 and §1.98, the Applicants submit for consideration in the above-identified patent application the document listed on the accompanying Form PTO-1449. Copies of the cited journal articles are not attached because they were previously submitted in US Patent Application No. 10/077,835 from which the present patent application claims priority. The Examiner is requested to make these journal articles of record. The remaining references are not attached hereto, because these references are issued patents or publications which are readily available in the U.S. Patent and Trademark Office.

This Information Disclosure Statement is submitted pursuant to 37 CFR §1.97(c) as it is after receipt of a first Office Action on the merits but before mailing of a final Action or Notice of Allowance. Accordingly, a fee is required pursuant to 37 CFR §1.17(p). A Fee Transmittal form (PTO/SB/17) is attached to this submission.

In addition, Applicants submit for the Examiner's consideration, the prosecution histories of the following co-owned applications/patents, cited by serial number, first named inventor and filing date. The Applicants presume that the Examiner has access to and will review the cited applications/patents and the files thereof for any office actions,

SILICON VALLEY PATENT GROUP LLP

2350 Mission College Blvd. Suite 360 Santa Clara, CA 95054 (408) 982-8200 FAX (408) 982-8210 amendments or other materials that may be relevant to the patentability of the claims of the present application.

Citation of the following prosecution histories (including the arguments against patentability advanced by Examiners in their respective Office Actions and the Applicants' arguments in the corresponding Amendments) is in accordance with the case DAYCO PRODUCTS, INC. v. TOTAL CONTAINMENT, INC., 02-1497, decided May 23, 2003 by the Court of Appeals for the Federal Circuit. The Examiner is presumed to be knowledgeable about the current case law, including the above-mentioned Dayco case. However, if the Examiner needs a copy of the Dayco case, please call the undersigned.

For any of the following U.S. patent application(s) that are currently pending, the Applicants further presume that the Examiner will consider any future office actions, amendments or other materials in the file thereof that may be relevant to the patentability of the claims herein. If the Applicants' understanding in this regard is not correct, please notify the undersigned so that copies of any such documents can be submitted to the Examiner.

	Serial No.:	First Named Inventor	Filing Date:
1.	10/077,835	Jaewan Hong	Feb 15, 2002
2.	10/755,750	Joonhyung Kwon	Jan 12, 2004

Applicants would appreciate the Examiner initialing and returning the Form PTO-1449, indicating that the information has been considered and made of record herein.

The information contained in this Information Disclosure Statement is to the best of my knowledge and is not to be construed as a representation that: (i) a complete search has been made; (ii) additional information material to the examination of this application does not exist; (iii) the information, protocols, results and the like reported by third parties are accurate or enabling; or (iv) the above information constitutes prior art to the subject invention.

Express Mail Label No.: EV 581 853 583 US

Respectfully submitted,

Omkar K. Suryadevara Attorney for Applicants

Reg. No. 36,320

SILICON VALLEY PATENT GROUP LLP

Mission College Blvd. Suite 360 lanta Clara, CA 95054 (408) 982-8200 FAX (408) 982-8210

U.S. Department of Commerce, Patent and Trademark Office	Application No.:	10/748,827
	Filing Date:	December 29, 2003
FEB 0 1 2005 STOLET	First Named Inventor:	Joonhyung Kwon
(B)	Group Art Unit:	2856
INFORMATION DISCLASSURE STATEMENT BY APPLICANT (Use several sheets if necessary)	Examiner Name:	Larkin, Daniel Sean
	Confirmation No.:	7166
	Attorney Docket No.:	PSI004-1C US

			U.S.	Patent Documents			- -		
*Examiner Intials		Document Number	Date	Name	Class	Subclass		Date in	
		US 5,672,816	09/1997	Park et al.	73	105		<u>-</u>	
		US 3,600,811	08/1971	Weyrauch, Adolf	33	707			
			Foreig	n Patent Documents		·	<u> </u>		
			- · · · · · · · · · · · · · · · · · · ·				Tran	Translation	
		Document	Date	Country	Class	Subclass	Yes	No	
		Other A	rt (Including Au	thor, Title, Date, Pertinent 1	Pages, Etc.)				
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	AS	Meyer, Gerhard e	t al, "Erratun: No	ovel optical approach to ato		copy", Appl. I	Phys. Le	tt.	
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	AY	"Dimension 3100	Scan Technique	s Unparalleled Power and V	•	ts Veeco Metro	ology G	roup,	
_	AZ	AutoProbe M5 TM Microscopes, Vee		Microscope, Microscopes \	Veeco Metrology	Group, 2001@	TM		
	BA "TappingMode Imaging: Application and Technology", www.di.com/AppNotes/TapMode/TapModeMain.html, Digital Instruments, Veeco Metrology Grou ©1995-2001, Digital Instruments, print date Dec. 17, 2001, 5 pages.						gy Grouj	p,	
	ВВ	"NanoScope Vert	ical Engage Scar	nner", www.di.com/Product 2001, Digital Instruments, p	s/Mult/JVScanne			nents	

ı	Examiner:	Date Considered:							
	* Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if								
Į	not in conformance and not considered. Include copy of this form	with your communication with applicant.							

U.S. Department of Commerce, Patent and Trademark Office	Application No.:	10/748,827
(Filing Date:	December 29, 2003
(O) mis of	First Named Inventor:	Joonhyung Kwon
\ \(\tag{6} \) \(\tag{8} \)	Group Art Unit:	2856
INFORMATION DISCOSURE STATEMENT BY APPLICANT	Examiner Name:	Larkin, Daniel Sean
(Use several sheets if necessary)	Confirmation No.:	7166
	Attorney Docket No.:	PSI004-1C US

			U.S.	Patent Documents						
*Examiner Intials		Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate			
		US 5,666,051	09/1997	Junker et al.	324	209				
	<u> </u>			<u> </u>		<u> </u>	<u> </u>			
			Foreig	n Patent Documents						
	Υ-							slation		
	-	Document	Date	Country	Class	Subclass	Yes	No		
		Other A	rt (Including Au	thor, Title, Date, Pertinent	Pages Etc.)			<u></u>		
<u> </u>	<u> </u>			Probe Microscope", www	,	/M. 16: /N /N // A 1.	ana htm	Digita		
	BC			oup, © 1996-2001, Digital	_		one.mm	i, Digita		
	<u> </u>	"NanoScope ® MultiMode TM SPM The World's Highest Resolution SPM",								
	BD	www.di.com/Prod	lucts/Multi/MMI	Main.html, Digital Instrume	ents Veeco Metro	ology Group, ©	1995-2	001,		
•		Digital Instruments, print date Dec. 17, 2001 7 pages.								
	BE	"Products", Digita	al Instruments, V	eeco Metrology Group Pro	ducts,					
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	BF			st Flexible Research SPM",		•	ucts/cp.	htm,		
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	ВК	1	esearch Scanning	g Probe Microscope", Ther	moMicroscopes,	4 pages, publi	shed pri	or to		
		Feb. 15, 2002								

ı	Examiner:	Date Considered:
ľ	* Examiner: Initial if reference is considered, whether or not citation	on is in conformance with MPEP 609; Draw line through citation if
Į	not in conformance and not considered. Include copy of this form	with your communication with applicant.

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U.S. Department of Commerce, Patent and Trademark Office	Application No.:	10/748,827	
	Filing Date:	December 29, 2003	
FEB 0 1 2005 E	First Named Inventor:	Joonhyung Kwon	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	Group Art Unit:	2856	
	Examiner Name:	Larkin, Daniel Sean	
(Use several sheets if necessary)	Confirmation No.:	7166	
	Attorney Docket No.:	PSI004-1C US	

			U.S. P	atent Documents	-	-		
*Examiner Intials		Document Number US 2001/0029674	Date 10/2001	Name Cutler, Donald R.	Class 33	Subclass 1.00M		Date if opriate
			Foreign	Patent Documents			L	
							Tran	slation
		Document	Date	Country	Class	Subclass	Yes	No
		Other A	rt (Including Auth	or, Title, Date, Pertinent F	Pages, Etc.)			
	BL			oMicroscopes, 4 pages, p		Feb. 15, 2002		
•	BM	"The Dimension ^{TI} 15, 2002	⁴ 5000 Scanning F	robe Microscope", Digita	l Instruments, 8	pages, publish	ed prior	to Feb.
•	BN	"The Dimension Th 15, 2002	^M 3000 Scanning F	Probe Microscope", Digita	l Instruments, 6	pages, publish	ed prior	to Feb.
	ВО	"The Dimension ^{TN} 15, 2002	3100 Scanning F	robe Microscope", Digita	l Instruments, 1	page, publishe	d prior t	o Feb.
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not in conformance and not considered. Include copy of this form with your communication with applicant.	